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Renesas Electronics website: <http://www.renesas.com>

April 1st, 2010
Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (<http://www.renesas.com>)

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256K-BIT CMOS STATIC RAM

32K-WORD BY 8-BIT

Description

The μ PD43256B is a high speed, low power, and 262,144 bits (32,768 words by 8 bits) CMOS static RAM.

Battery backup is available. And A and B versions are wide voltage operations.

The μ PD43256B is packed in 28-pin PLASTIC SOP and 28-pin PLASTIC TSOP (I) (8 x 13.4 mm).

Features

- 32,768 words by 8 bits organization
- Fast access time: 70, 85, 100, 120 ns (MAX.)
- Low voltage operation (A version: $V_{CC} = 3.0$ to 5.5 V, B version: $V_{CC} = 2.7$ to 5.5 V)
- Low V_{CC} data retention: 2.0 V (MIN.)
- /OE input for easy application

Part number	Access time ns (MAX.)	Operating supply voltage V	Operating ambient temperature °C	Supply current		
				At operating mA (MAX.)	At standby μ A (MAX.)	At data retention μ A (MAX.) ^{Note1}
μ PD43256B-xxL	70, 85	4.5 to 5.5	0 to 70	45	50	3
μ PD43256B-xxLL					15	2
μ PD43256B-Axx	85, 100 ^{Note2} , 120 ^{Note2}	3.0 to 5.5				
μ PD43256B-Bxx ^{Note2}	100, 120	2.7 to 5.5				

Notes 1. $T_A \leq 40$ °C, $V_{CC} = 3.0$ V

2. Access time: 85 ns (MAX.) ($V_{CC} = 4.5$ to 5.5 V)

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Ordering Information

Part number	Package	Access time ns (MAX.)	Operating supply voltage V	Operating ambient temperature °C	Remark
μPD43256BGU-70L	28-pin PLASTIC SOP (11.43 mm (450))	70	4.5 to 5.5	0 to 70	L version
μPD43256BGU-85L		85			
μPD43256BGU-70LL		70			LL version
μPD43256BGU-85LL		85			
μPD43256BGU-A85		85	3.0 to 5.5		A version
μPD43256BGU-A10		100			
μPD43256BGU-A12		120			
μPD43256BGU-B12		120	2.7 to 5.5		B version
μPD43256BGW-70LL-9JL	28-pin PLASTIC TSOP (I) (8x13.4) (Normal bent)	70	4.5 to 5.5	0 to 70	LL version
μPD43256BGW-85LL-9JL		85			
μPD43256BGU-70L-A	28-pin PLASTIC SOP (11.43 mm (450))	70	4.5 to 5.5		L version
μPD43256BGU-85L-A		85			
μPD43256BGU-70LL-A		70			LL version
μPD43256BGU-85LL-A		85			
μPD43256BGU-A85-A		85	3.0 to 5.5		A version
μPD43256BGU-A10-A		100			
μPD43256BGU-A12-A		120			
μPD43256BGU-B10-A		100	2.7 to 5.5		B version
μPD43256BGU-B12-A	120				
μPD43256BGW-70LL-9JL-A	28-pin PLASTIC TSOP (I) (8x13.4) (Normal bent)	70	4.5 to 5.5	LL version	
μPD43256BGW-85LL-9JL-A		85			

Remark Products with -A at the end of the part number are lead-free products.

Pin Configurations (Marking Side)

/xxx indicates active low signal.

28-pin PLASTIC SOP (11.43 mm (450))

[μPD43256BGU-xxL]

[μPD43256BGU-xxLL]

[μPD43256BGU-Axx]

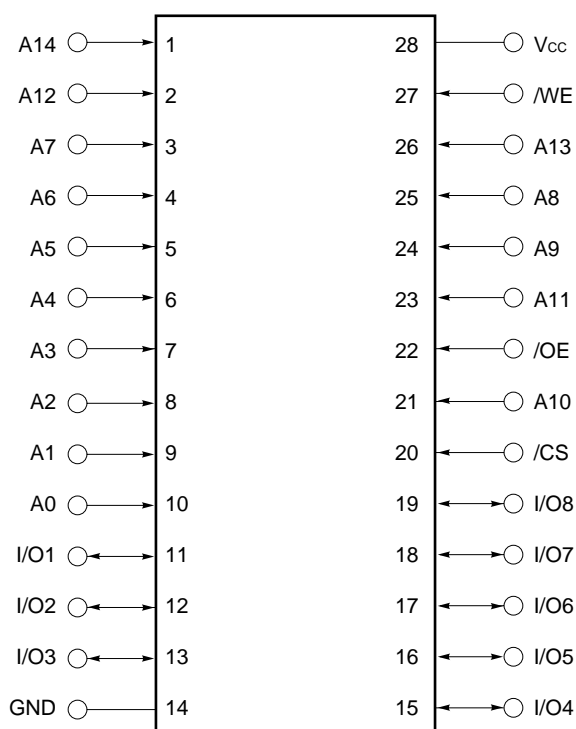
[μPD43256BGU-Bxx]

[μPD43256BGU-xxL-A]

[μPD43256BGU-xxLL-A]

[μPD43256BGU-Axx-A]

[μPD43256BGU-Bxx-A]



A0 - A14 : Address inputs

I/O1 - I/O8 : Data inputs / outputs

/CS : Chip Select

/WE : Write Enable

/OE : Output Enable

V_{cc} : Power supply

GND : Ground

Remark Refer to **Package Drawings** for the 1-pin index mark.

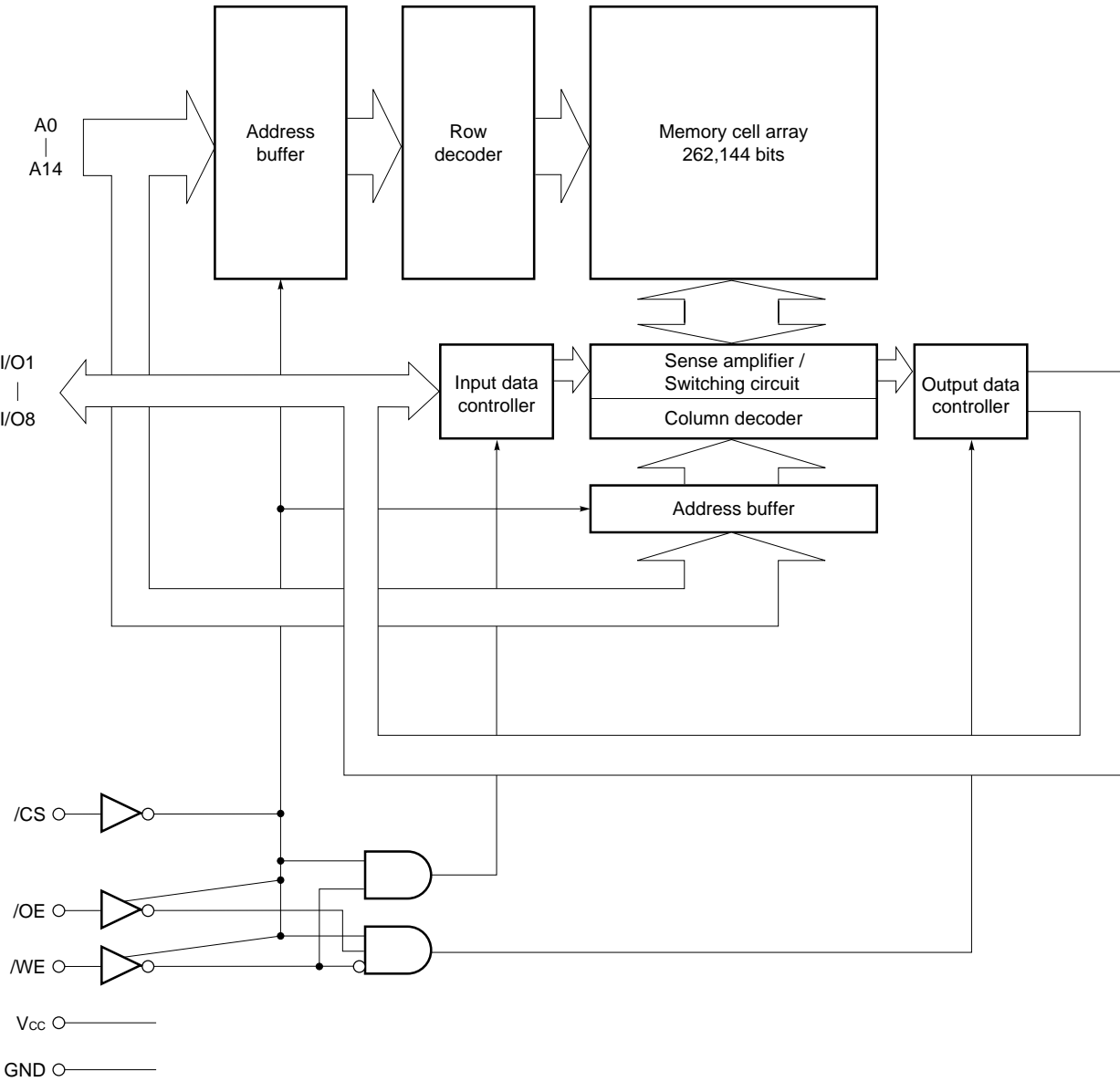
28-pin PLASTIC TSOP (I) (8x13.4) (Normal bent)

[μ PD43256BGW-xxLL-9JL][μ PD43256BGW-Axx-9JL][μ PD43256BGW-Bxx-9JL][μ PD43256BGW-xxLL-9JL-A][μ PD43256BGW-Axx-9JL-A][μ PD43256BGW-Bxx-9JL-A]

A0 - A14 : Address inputs /OE : Output Enable
 I/O1 - I/O8 : Data inputs / outputs Vcc : Power supply
 /CS : Chip Select GND : Ground
 /WE : Write Enable

Remark Refer to **Package Drawings** for the 1-pin index mark.

Block Diagram



Truth Table

/CS	/OE	/WE	Mode	I/O	Supply current
H	×	×	Not selected	High impedance	I _{SB}
L	H	H	Output disable		I _{CCA}
L	×	L	Write	D _{IN}	
L	L	H	Read	D _{OUT}	

Remark × : V_{IH} or V_{IL}

Electrical Specifications

Absolute Maximum Ratings

Parameter	Symbol	Condition	Rating	Unit
Supply voltage	V_{CC}		-0.5^{Note} to $+7.0$	V
Input / Output voltage	V_T		-0.5^{Note} to $V_{CC} + 0.5$	V
Operating ambient temperature	T_A		0 to 70	°C
Storage temperature	T_{stg}		-55 to $+125$	°C

Note -3.0 V (MIN.) (Pulse width : 50 ns)

Caution Exposing the device to stress above those listed in Absolute Maximum Rating could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

Recommended Operating Conditions

Parameter	Symbol	Condition	μ PD43256B-xxL μ PD43256B-xxLL		μ PD43256B-Axx		μ PD43256B-Bxx		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Supply voltage	V_{CC}		4.5	5.5	3.0	5.5	2.7	5.5	V
High level input voltage	V_{IH}		2.2	$V_{CC}+0.5$	2.2	$V_{CC}+0.5$	2.2	$V_{CC}+0.5$	V
Low level input voltage	V_{IL}		-0.3^{Note}	+0.8	-0.3^{Note}	+0.5	-0.3^{Note}	+0.5	V
Operating ambient temperature	T_A		0	70	0	70	0	70	°C

Note -3.0 V (MIN.) (Pulse width: 50 ns)

Capacitance ($T_A = 25$ °C, $f = 1$ MHz)

Parameter	Symbol	Test conditions	MIN.	TYP.	MAX.	Unit
Input capacitance	C_{IN}	$V_{IN} = 0$ V			5	pF
Input / Output capacitance	$C_{I/O}$	$V_{I/O} = 0$ V			8	pF

Remarks 1. V_{IN} : Input voltage

$V_{I/O}$: Input / Output voltage

2. These parameters are periodically sampled and not 100% tested.

DC Characteristics (Recommended Operating Conditions Unless Otherwise Noted) (1/2)

Parameter	Symbol	Test condition	μPD43256B-xxL			μPD43256B-xxLL			Unit
			MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Input leakage current	I _{LI}	V _{IN} = 0 V to V _{CC}	-1.0		+1.0	-1.0		+1.0	μA
I/O leakage current	I _{LO}	V _{I/O} = 0 V to V _{CC} , /OE = V _{IH} or /CS = V _{IH} or /WE = V _{IL}	-1.0		+1.0	-1.0		+1.0	μA
Operating supply current	I _{CCA1}	/CS = V _{IL} , Minimum cycle time, I _{I/O} = 0 mA			45			45	mA
	I _{CCA2}	/CS = V _{IL} , I _{I/O} = 0 mA			10			10	
	I _{CCA3}	/CS ≤ 0.2 V, Cycle = 1 MHz, I _{I/O} = 0 mA, V _{IL} ≤ 0.2 V, V _{IH} ≥ V _{CC} - 0.2 V			10			10	
Standby supply current	I _{SB}	/CS = V _{IH}			3			3	mA
	I _{SB1}	/CS ≥ V _{CC} - 0.2 V		1.0	50		0.5	15	
High level output voltage	V _{OH1}	I _{OH} = -1.0 mA	2.4			2.4			V
	V _{OH2}	I _{OH} = -0.1 mA	V _{CC} -0.5			V _{CC} -0.5			
Low level output voltage	V _{OL}	I _{OL} = 2.1 mA			0.4			0.4	V

Remarks 1. V_{IN} : Input voltage

V_{I/O} : Input / Output voltage

2. These DC characteristics are in common regardless of package types.

DC Characteristics (Recommended Operating Conditions Unless Otherwise Noted) (2/2)

Parameter	Symbol	Test condition	μ PD43256B-Axx			μ PD43256B-Bxx			Unit
			MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Input leakage current	I_{LI}	$V_{IN} = 0 \text{ V to } V_{CC}$	-1.0		+1.0	-1.0		+1.0	μA
I/O leakage current	I_{LO}	$V_{I/O} = 0 \text{ V to } V_{CC}$, $/OE = V_{IH}$ or $/CS = V_{IH}$ or $/WE = V_{IL}$	-1.0		+1.0	-1.0		+1.0	μA
Operating supply current	I_{CCA1}	$/CS = V_{IL}$, Minimum cycle time, $I_{I/O} = 0 \text{ mA}$	μ PD43256B-Axx		45			—	mA
			μ PD43256B-Bxx		—			45	
		$V_{CC} \leq 3.3 \text{ V}$			—			20	
	I_{CCA2}	$/CS = V_{IL}$, $I_{I/O} = 0 \text{ mA}$			10			10	
		$V_{CC} \leq 3.3 \text{ V}$			—			5	
	I_{CCA3}	$/CS \leq 0.2 \text{ V}$, Cycle = 1 MHz, $I_{I/O} = 0 \text{ mA}$, $V_{IL} \leq 0.2 \text{ V}$, $V_{IH} \geq V_{CC} - 0.2 \text{ V}$			10			10	
Standby supply current	I_{SB}	$/CS = V_{IH}$			3			3	mA
		$V_{CC} \leq 3.3 \text{ V}$			—			2	
	I_{SB1}	$/CS \geq V_{CC} - 0.2 \text{ V}$		0.5	15		0.5	15	μA
		$V_{CC} \leq 3.3 \text{ V}$			—		0.5	10	
High level output voltage	V_{OH1}	$I_{OH} = -1.0 \text{ mA}$, $V_{CC} \geq 4.5 \text{ V}$	2.4			2.4			V
		$I_{OH} = -0.5 \text{ mA}$, $V_{CC} < 4.5 \text{ V}$	2.4			2.4			
	V_{OH2}	$I_{OH} = -0.02 \text{ mA}$	$V_{CC}-0.1$			$V_{CC}-0.1$			
Low level output voltage	V_{OL}	$I_{OL} = 2.1 \text{ mA}$, $V_{CC} \geq 4.5 \text{ V}$			0.4			0.4	V
		$I_{OL} = 1.0 \text{ mA}$, $V_{CC} < 4.5 \text{ V}$			0.4			0.4	
	V_{OL1}	$I_{OL} = 0.02 \text{ mA}$			0.1			0.1	

Remarks 1. V_{IN} : Input voltage

$V_{I/O}$: Input / Output voltage

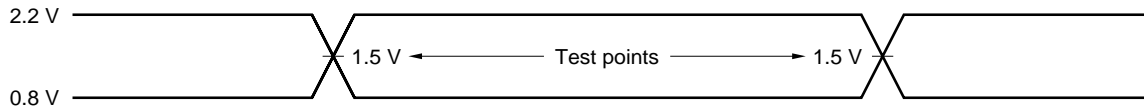
2. These DC characteristics are in common regardless of package types.

AC Characteristics (Recommended Operating Conditions Unless Otherwise Noted)

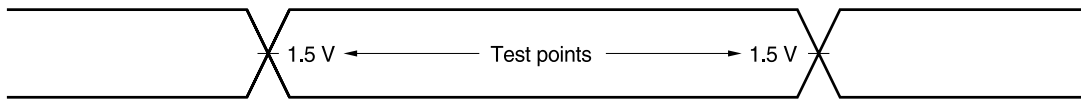
AC Test Conditions

[μPD43256B-70L, μPD43256B-85L, μPD43256B-70LL, μPD43256B-85LL]

Input Waveform (Rise and Fall Time ≤ 5 ns)



Output Waveform



Output Load

AC characteristics should be measured with the following output load conditions.

Figure 1

(t_{AA} , t_{ACS} , t_{OE} , t_{OH})

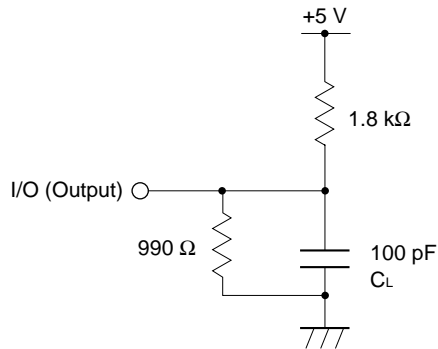
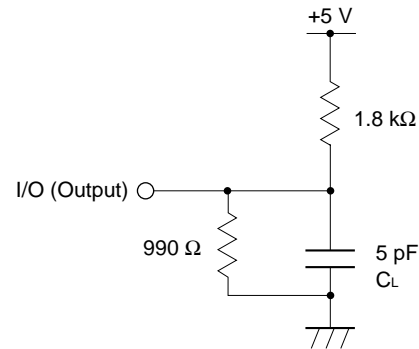


Figure 2

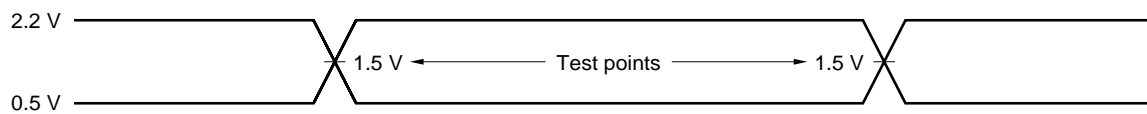
(t_{CHZ} , t_{CLZ} , t_{OHZ} , t_{OLZ} , t_{WHZ} , t_{OW})



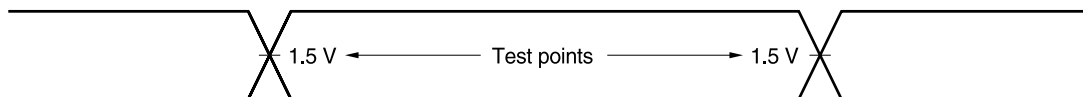
Remark C_L includes capacitance of the probe and jig, and stray capacitance.

[μPD43256B-A85, μPD43256B-A10, μPD43256B-A12, μPD43256B-B10, μPD43256B-B12]

Input Waveform (Rise and Fall Time ≤ 5 ns)



Output Waveform



Output Load

AC characteristics should be measured with the following output load conditions.

t_{AA} , t_{ACS} , t_{OE} , t_{OH}	t_{CHZ} , t_{CLZ} , t_{OHZ} , t_{OLZ} , t_{WHZ} , t_{OW}
1TTL + 100 pF	1TTL + 5 pF

Read Cycle (1/2)

Parameter	Symbol	V _{CC} ≥ 4.5 V				Unit	Condition
		μPD43256B-70		μPD43256B-85 μPD43256B-A85/A10/A12 μPD43256B-B10/B12			
		MIN.	MAX.	MIN.	MAX.		
Read cycle time	t _{RC}	70		85		ns	Note
Address access time	t _{AA}		70		85	ns	
/CS access time	t _{ACS}		70		85	ns	
/OE access time	t _{OE}		35		40	ns	
Output hold from address change	t _{OH}	10		10		ns	
/CS to output in low impedance	t _{CLZ}	10		10		ns	
/OE to output in low impedance	t _{OLZ}	5		5		ns	
/CS to output in high impedance	t _{CHZ}		30		30	ns	
/OE to output in high impedance	t _{OHZ}		30		30	ns	

Note See the **output load**.

Remark These AC characteristics are in common regardless of package types and L, LL versions.

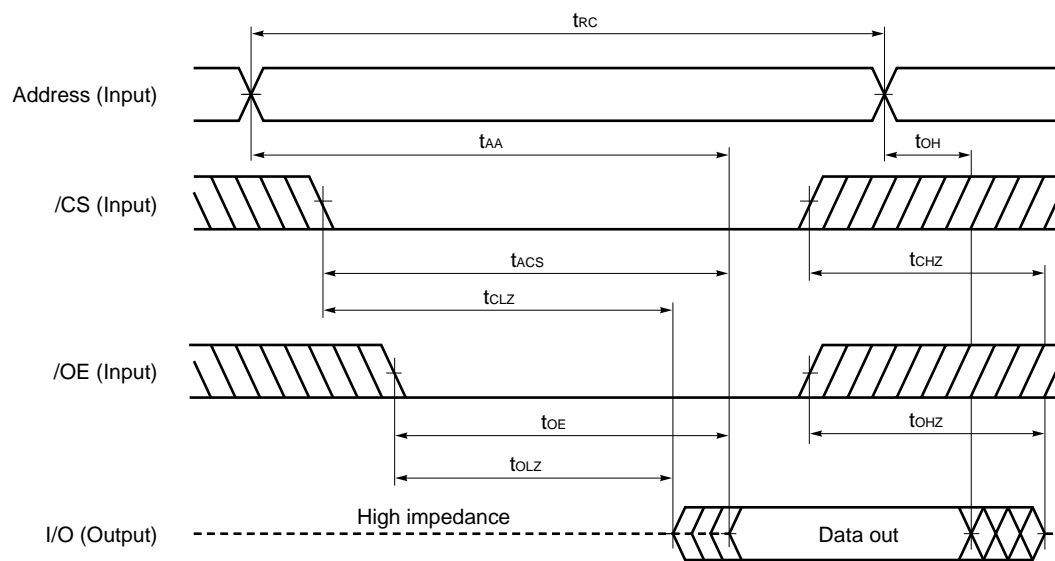
Read Cycle (2/2)

Parameter	Symbol	V _{CC} ≥ 3.0 V						V _{CC} ≥ 2.7 V				Unit	Condition
		μPD43256B -A85		μPD43256B -A10		μPD43256B -A12		μPD43256B -B10		μPD43256B -B12			
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Read cycle time	t _{RC}	85		100		120		100		120		ns	Note
Address access time	t _{AA}		85		100		120		100		120	ns	
/CS access time	t _{ACS}		85		100		120		100		120	ns	
/OE access time	t _{OE}		50		60		60		60		60	ns	
Output hold from address change	t _{OH}	10		10		10		10		10		ns	
/CS to output in low impedance	t _{CLZ}	10		10		10		10		10		ns	
/OE to output in low impedance	t _{OLZ}	5		5		5		5		5		ns	
/CS to output in high impedance	t _{CHZ}		35		35		40		35		40	ns	
/OE to output in high impedance	t _{OHZ}		35		35		40		35		40	ns	

Note See the **output load**.

Remark These AC characteristics are in common regardless of package types.

Read Cycle Timing Chart



Remark In read cycle, /WE should be fixed to high level.

Write Cycle (1/2)

Parameter	Symbol	V _{CC} ≥ 4.5 V				Unit	Condition
		μPD43256B-70		μPD43256B-85 μPD43256B-A85/A10/A12 μPD43256B-B10/B12			
		MIN.	MAX.	MIN.	MAX.		
Write cycle time	t _{wc}	70		85		ns	
/CS to end of write	t _{cw}	50		70		ns	
Address valid to end of write	t _{aw}	50		70		ns	
Write pulse width	t _{wP}	55		60		ns	
Data valid to end of write	t _{dW}	30		35		ns	
Data hold time	t _{dH}	0		0		ns	
Address setup time	t _{aS}	0		0		ns	
Write recovery time	t _{wR}	0		0		ns	
/WE to output in high impedance	t _{wHZ}		30		30	ns	Note
Output active from end of write	t _{oW}	10		10		ns	

Note See the **output load**.

Remark These AC characteristics are in common regardless of package types and L, LL versions.

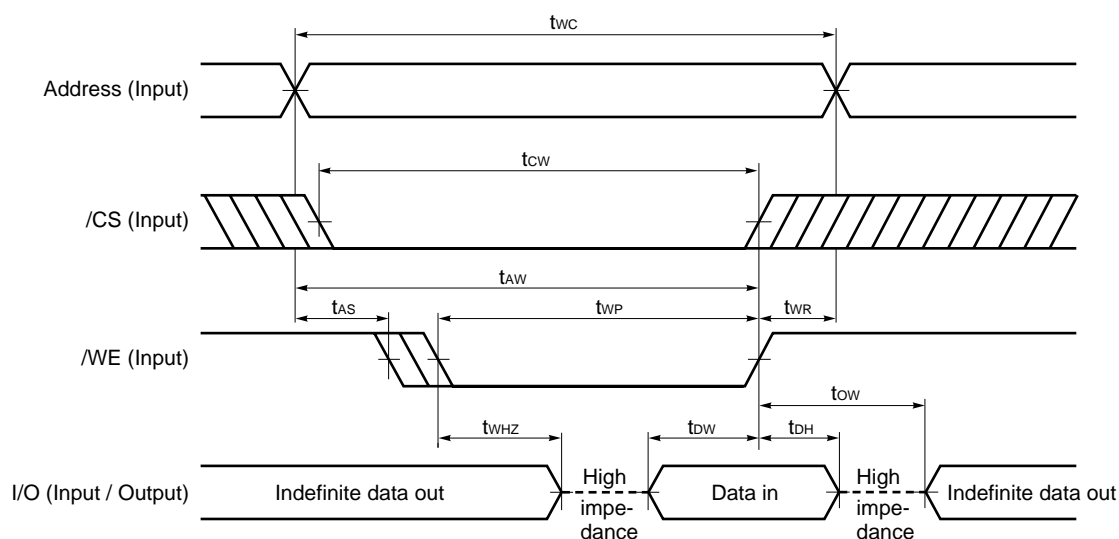
Write Cycle (2/2)

Parameter	Symbol	V _{CC} ≥ 3.0 V						V _{CC} ≥ 2.7 V				Unit	Condition
		μPD43256B -A85		μPD43256B -A10		μPD43256B -A12		μPD43256B -B10		μPD43256B -B12			
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Write cycle time	t _{WC}	85		100		120		100		120		ns	
/CS to end of write	t _{CW}	70		70		90		70		90		ns	
Address valid to end of write	t _{AW}	70		70		90		70		90		ns	
Write pulse width	t _{WP}	60		60		80		60		80		ns	
Data valid to end of write	t _{DW}	60		60		70		60		70		ns	
Data hold time	t _{DH}	0		0		0		0		0		ns	
Address setup	t _{AS}	0		0		0		0		0		ns	
Write recovery	t _{WR}	0		0		0		0		0		ns	
/WE to output in high impedance	t _{WHZ}		30		35		40		35		40	ns	Note
Output active from end of write	t _{OW}	10		10		10		10		10		ns	

Note See the **output load**.

Remark These AC characteristics are in common regardless of package types.

Write Cycle Timing Chart 1 (/WE Controlled)



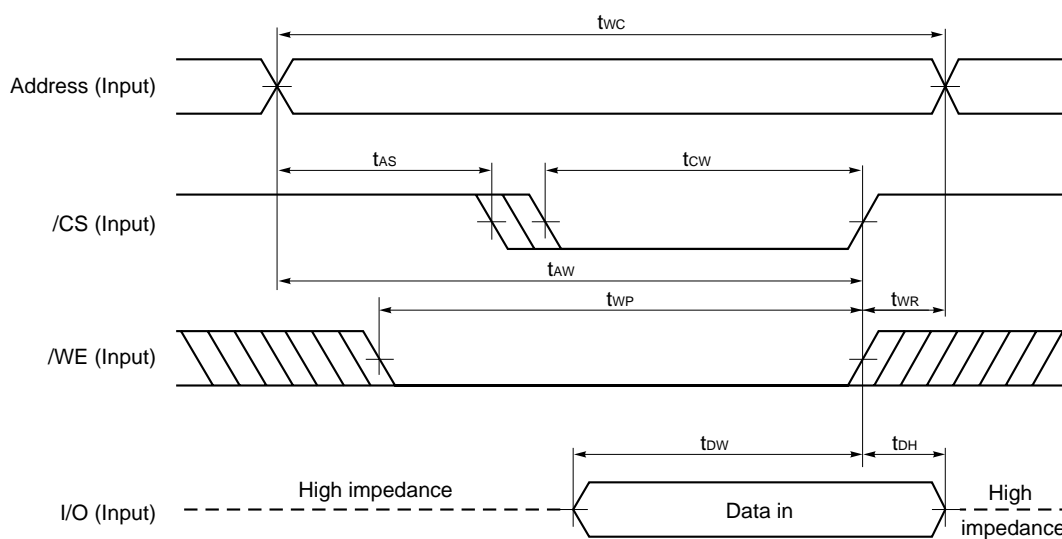
Cautions 1. \overline{CS} or \overline{WE} should be fixed to high level during address transition.

2. When I/O pins are in the output state, therefore the input signals must not be applied to the output.

Remarks 1. Write operation is done during the overlap time of a low level \overline{CS} and a low level \overline{WE} .

2. When \overline{WE} is at low level, the I/O pins are always high impedance. When \overline{WE} is at high level, read operation is executed. Therefore \overline{OE} should be at high level to make the I/O pins high impedance.
3. If \overline{CS} changes to low level at the same time or after the change of \overline{WE} to low level, the I/O pins will remain high impedance state.

Write Cycle Timing Chart 2 (/CS Controlled)



- Cautions**
1. /CS or /WE should be fixed to high level during address transition.
 2. When I/O pins are in the output state, therefore the input signals must not be applied to the output.

Remark Write operation is done during the overlap time of a low level /CS and a low level /WE.

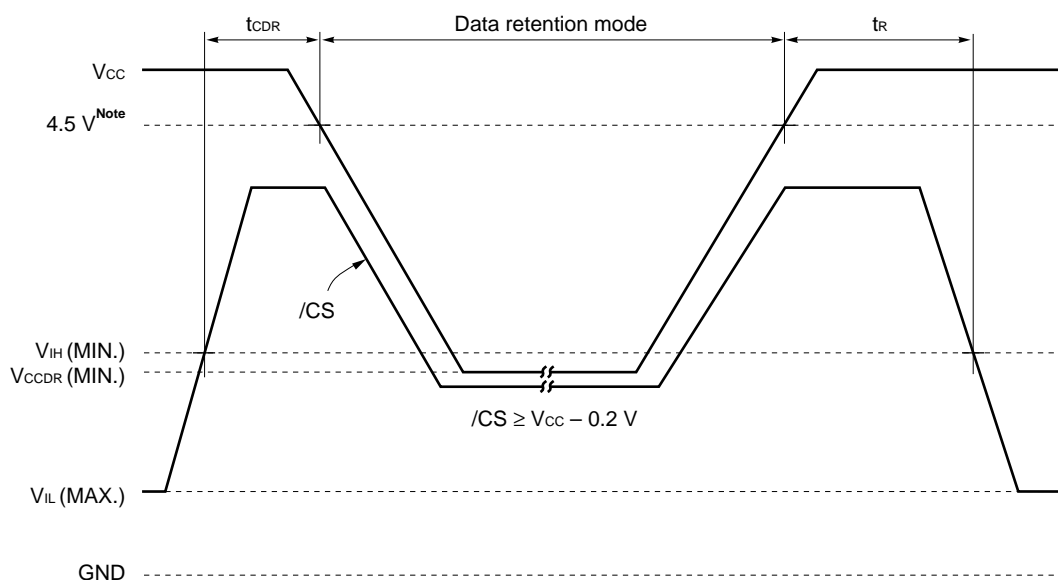
Low V_{CC} Data Retention Characteristics (T_A = 0 to 70 °C)

Parameter	Symbol	Test Condition	μPD43256B-xxL			μPD43256B-xxLL μPD43256B-Axx μPD43256B-Bxx			Unit
			MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
Data retention supply voltage	V _{CCDR}	/CS ≥ V _{CC} – 0.2 V	2.0		5.5	2.0		5.5	V
Data retention supply current	I _{CCDR}	V _{CC} = 3.0 V, /CS ≥ V _{CC} – 0.2 V		0.5	20 ^{Note1}		0.5	7 ^{Note2}	μA
Chip deselection to data retention mode	t _{CDR}		0			0			ns
Operation recovery time	t _r		5			5			ms

Notes 1. 3 μA (T_A ≤ 40 °C)

2. 2 μA (T_A ≤ 40 °C), 1 μA (T_A ≤ 25 °C)

Data Retention Timing Chart

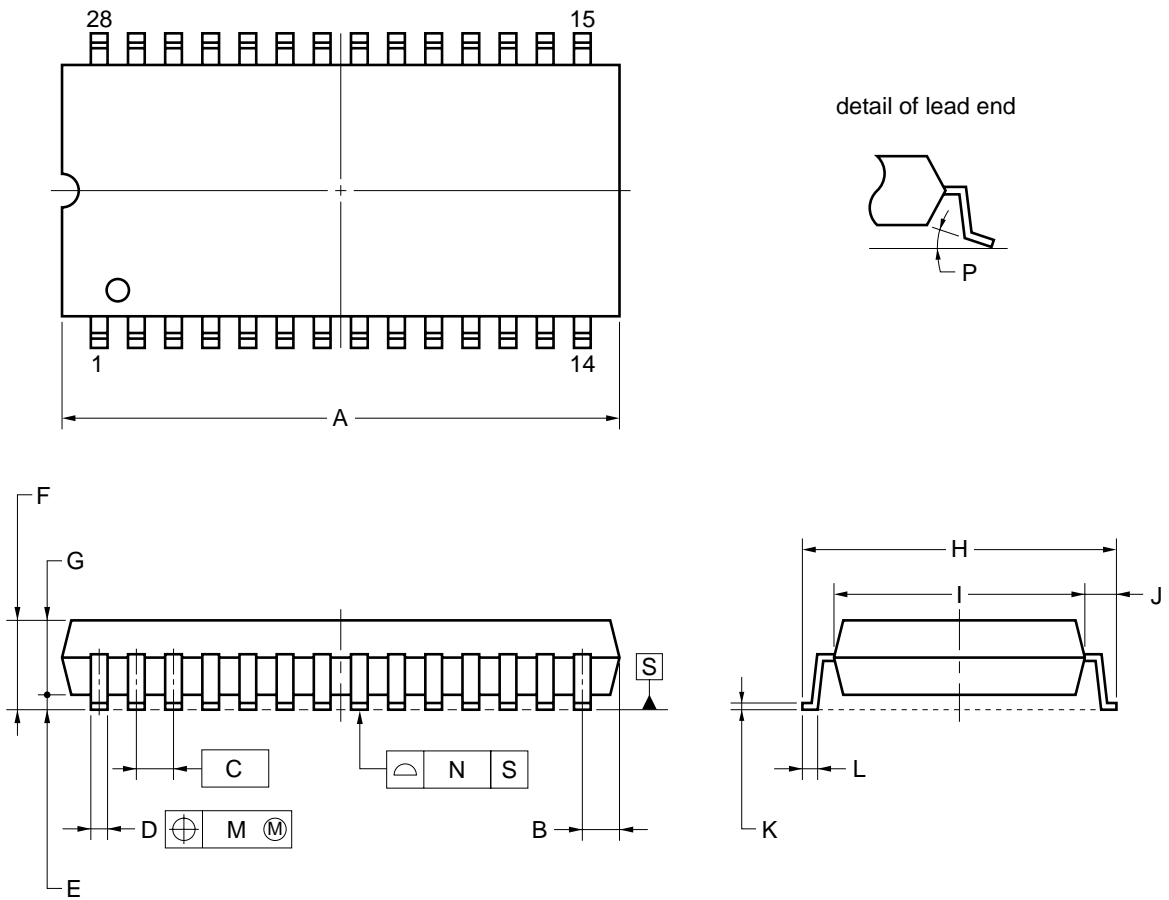


Note A version : 3.0 V, B version : 2.7 V

Remark The other pins (Address, /OE, /WE, I/O) can be in high impedance state.

Package Drawings

28-PIN PLASTIC SOP (11.43 mm (450))

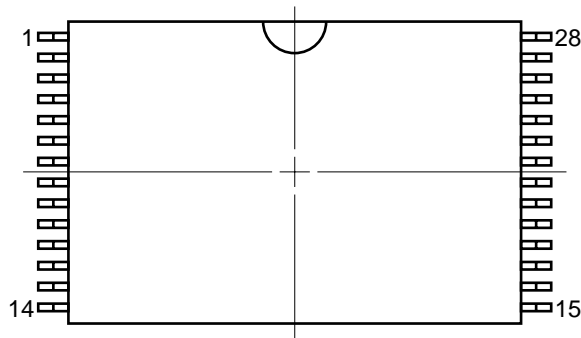


NOTE
Each lead centerline is located within 0.12 mm of its true position (T.P.) at maximum material condition.

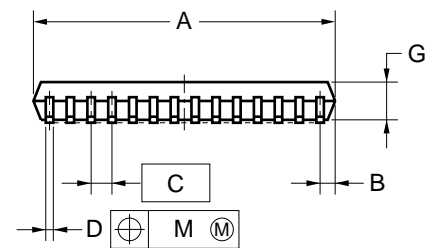
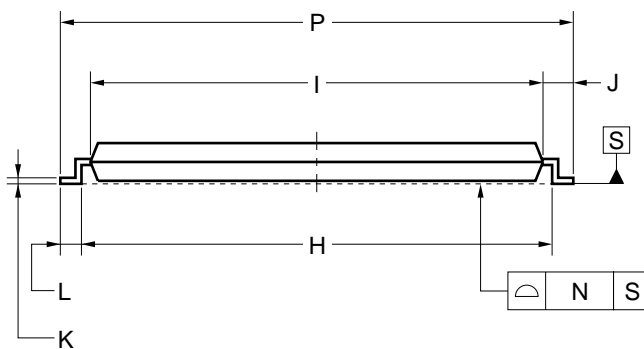
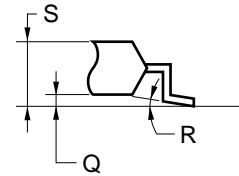
ITEM	MILLIMETERS
A	18.0 ^{+0.6} _{-0.05}
B	1.27 MAX.
C	1.27 (T.P.)
D	0.42 ^{+0.08} _{-0.07}
E	0.2±0.1
F	2.95 MAX.
G	2.55±0.1
H	11.8±0.3
I	8.4±0.1
J	1.7±0.2
K	0.22±0.05
L	0.7±0.2
M	0.12
N	0.10
P	3° ^{+7°} _{-3°}

P28GU-50-450A-4

28-PIN PLASTIC TSOP(I) (8x13.4)



detail of lead end



NOTES

- Each lead centerline is located within 0.08 mm of its true position (T.P.) at maximum material condition.
- "A" excludes mold flash. (Includes mold flash : 8.4mm MAX.)

ITEM	MILLIMETERS
A	8.0±0.1
B	0.6 MAX.
C	0.55 (T.P.)
D	0.22 ^{+0.08} _{-0.07}
G	1.0
H	12.4±0.2
I	11.8±0.1
J	0.8±0.2
K	0.145 ^{+0.025} _{-0.015}
L	0.5±0.1
M	0.08
N	0.10
P	13.4±0.2
Q	0.1±0.05
R	3° ^{+7°} _{-3°}
S	1.2 MAX.

P28GW-55-9JL-2

Recommended Soldering Conditions

Please consult with our sales offices for soldering conditions of the μ PD43256B.

Types of Surface Mount Device

μ PD43256BGU-xxL	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGU-xxLL	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGU-Axx	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGU-Bxx	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGW-xxLL-9JL	: 28-pin PLASTIC TSOP (I) (8x13.4) (Normal bent)
μ PD43256BGU-xxL-A	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGU-xxLL-A	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGU-Axx-A	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGU-Bxx-A	: 28-pin PLASTIC SOP (11.43 mm (450))
μ PD43256BGW-xxLL-9JL-A	: 28-pin PLASTIC TSOP (I) (8x13.4) (Normal bent)

Quality Grade

- A quality grade of the products is "Standard".
- Anti-radioactive design is not implemented in the products.
- Semiconductor devices have the possibility of unexpected defects by affection of cosmic ray that reach to the ground and so forth.

Revision History

Edition/ Date	Page		Type of revision	Description
	This edition	Previous edition		
16th edition/ Nov. 2009	through	through	Modification	Ordering Information revised.

[MEMO]

[MEMO]

[MEMO]

NOTES FOR CMOS DEVICES

① VOLTAGE APPLICATION WAVEFORM AT INPUT PIN

Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between V_{IL} (MAX) and V_{IH} (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between V_{IL} (MAX) and V_{IH} (MIN).

② HANDLING OF UNUSED INPUT PINS

Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to V_{DD} or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.

③ PRECAUTION AGAINST ESD

A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.

④ STATUS BEFORE INITIALIZATION

Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.

⑤ POWER ON/OFF SEQUENCE

In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current.

The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.

⑥ INPUT OF SIGNAL DURING POWER OFF STATE

Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

- **The information in this document is current as of November, 2009. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC Electronics data sheets, etc., for the most up-to-date specifications of NEC Electronics products. Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.**

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